

<b>Notice of References Cited</b>	Application/Control No. 10/521,034	Applicant(s)/Patent Under Reexamination LEE, JAE-KUN	
	Examiner Rachel R. Steitz	Art Unit 3732	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,711,454	01-1998	Kobayashi et al.	222/95
	B	US-			
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	D	US-			
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